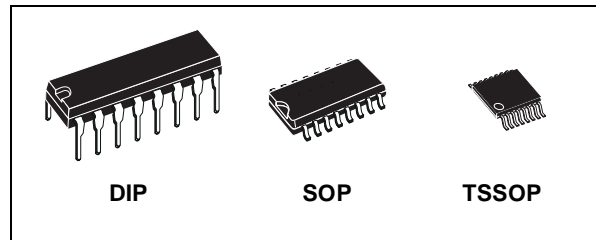




# M74HC123

## DUAL RETRIGGERABLE MONOSTABLE MULTIVIBRATOR

- HIGH SPEED :  
 $t_{PD} = 23 \text{ ns}$  (TYP.) at  $V_{CC} = 6V$
- LOW POWER DISSIPATION:  
 STAND BY STATE :  
 $I_{CC} = 4\mu A$  (MAX.) at  $T_A = 25^\circ C$   
 ACTIVE STATE :  
 $I_{CC} = 200\mu A$  (MAX.) at  $V_{CC} = 5V$
- HIGH NOISE IMMUNITY:  
 $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (MIN.)
- SYMMETRICAL OUTPUT IMPEDANCE:  
 $|I_{OH}| = I_{OL} = 4mA$  (MIN)
- BALANCED PROPAGATION DELAYS:  
 $t_{PLH} \cong t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE:  
 $V_{CC}$  (OPR) = 2V to 6V
- WIDE OUTPUT PULSE WIDTH RANGE :  
 $t_{WOUT} = 120 \text{ ns} \sim 60 \text{ s}$  OVER AT  $V_{CC} = 4.5 \text{ V}$
- PIN AND FUNCTION COMPATIBLE WITH  
 74 SERIES 123



### ORDER CODES

PACKAGE	TUBE	T & R
DIP	M74HC123B1R	
SOP	M74HC123M1R	M74HC123RM13TR
TSSOP		M74HC123TTR

### DESCRIPTION

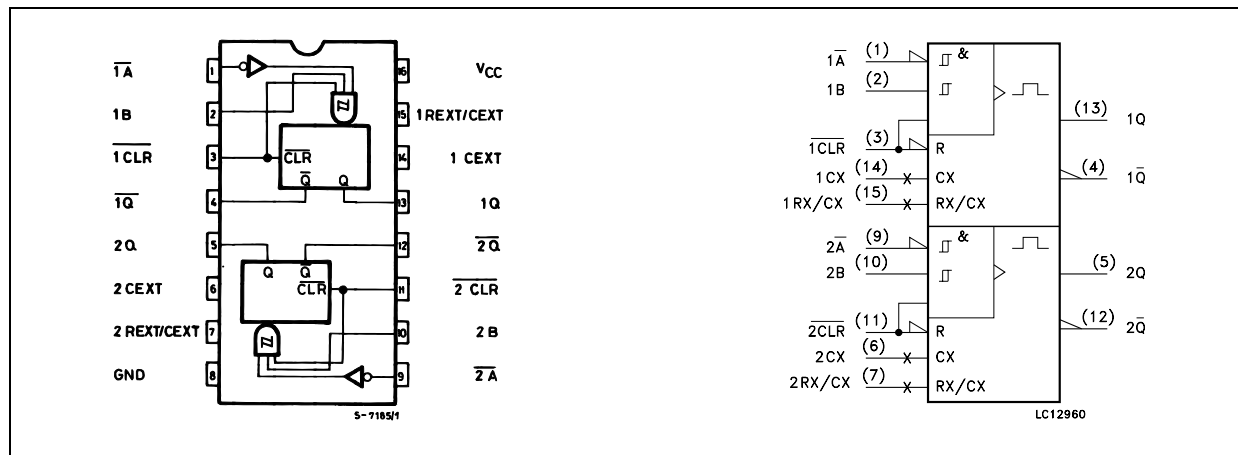
The M74HC123 is a high speed CMOS MONOSTABLE MULTIVIBRATOR fabricated with silicon gate C<sup>2</sup>MOS technology. There are two trigger inputs, A INPUT (negative edge) and B INPUT (positive edge). These inputs are valid for slow rising/falling signals, ( $t_r = t_f = 1 \text{ sec}$ ). The device may also be triggered by using the CLR input (positive-edge) because of the Schmitt-trigger input; after triggering the output maintains the MONOSTABLE state for the

period determined by the external resistor Rx and capacitor Cx. When  $C_x \geq 10nF$  and  $R_x \geq 10K\Omega$ , the output pulse width value is approximately given by the formula :  $tW(OUT) = K \cdot C_x \cdot R_x$ . ( $K \cong 0.45$ ).

Taking CLR low breaks this MONOSTABLE STATE. If the next trigger pulse occurs during the MONOSTABLE period it makes the MONOSTABLE period longer. Limit for values of Cx and Rx : Cx : NO LIMIT  
 $R_x : V_{CC} < 3.0V \text{ } 5K\Omega \text{ to } 1M\Omega$   
 $V_{CC} \geq 3.0V \text{ } 1K\Omega \text{ to } 1M\Omega$

All inputs are equipped with protection circuits against static discharge and transient excess voltage.

### PIN CONNECTION AND IEC LOGIC SYMBOLS



**ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	-0.5 to +7	V
$V_I$	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
$I_{IK}$	DC Input Diode Current	$\pm 20$	mA
$I_{OK}$	DC Output Diode Current	$\pm 20$	mA
$I_O$	DC Output Current	$\pm 25$	mA
$I_{CC}$ or $I_{GND}$	DC $V_{CC}$ or Ground Current	$\pm 50$	mA
$P_D$	Power Dissipation	500(*)	mW
$T_{stg}$	Storage Temperature	-65 to +150	°C
$T_L$	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied

(\*) 500mW at 65 °C; derate to 300mW by 10mW/°C from 65°C to 85°C

**RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Value	Unit	
$V_{CC}$	Supply Voltage	2 to 6	V	
$V_I$	Input Voltage	0 to $V_{CC}$	V	
$V_O$	Output Voltage	0 to $V_{CC}$	V	
$T_{op}$	Operating Temperature	-55 to 125	°C	
$t_r, t_f$	Input Rise and Fall Time	$V_{CC} = 2.0V$	0 to 1000	ns
		$V_{CC} = 4.5V$	0 to 500	ns
		$V_{CC} = 6.0V$	0 to 400	ns
$C_x$	External Capacitor	NO LIMITATION	pF	
$R_x$	External Resistor	$V_{CC} < 3V$	5K to 1M	$\Omega$
		$V_{CC} \geq 3V$	1K to 1M	

The Maximum allowable values of  $C_x$  and  $R_x$  are a function of leakage of capacitor  $C_x$ , the leakage of device and leakage due to the board layout and surface resistance. Susceptibility to externally induced noise may occur for  $R_x > 1M\Omega$

## DC SPECIFICATIONS

Symbol	Parameter	Test Condition		Value						Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25°C			-40 to 85°C		-55 to 125°C		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
V <sub>IH</sub>	High Level Input Voltage	2.0		1.5			1.5		1.5		V
		4.5		3.15			3.15		3.15		
		6.0		4.2			4.2		4.2		
V <sub>IL</sub>	Low Level Input Voltage	2.0				0.5		0.5		0.5	V
		4.5				1.35		1.35		1.35	
		6.0				1.8		1.8		1.8	
V <sub>OH</sub>	High Level Output Voltage	2.0	I <sub>O</sub> =-20 μA	1.9	2.0		1.9		1.9		V
		4.5	I <sub>O</sub> =-20 μA	4.4	4.5		4.4		4.4		
		6.0	I <sub>O</sub> =-20 μA	5.9	6.0		5.9		5.9		
		4.5	I <sub>O</sub> =-4.0 mA	4.18	4.31		4.13		4.10		
		6.0	I <sub>O</sub> =-5.2 mA	5.68	5.8		5.63		5.60		
V <sub>OL</sub>	Low Level Output Voltage	2.0	I <sub>O</sub> =20 μA		0.0	0.1		0.1		0.1	V
		4.5	I <sub>O</sub> =20 μA		0.0	0.1		0.1		0.1	
		6.0	I <sub>O</sub> =20 μA		0.0	0.1		0.1		0.1	
		4.5	I <sub>O</sub> =4.0 mA		0.17	0.26		0.33		0.40	
		6.0	I <sub>O</sub> =5.2 mA		0.18	0.26		0.33		0.40	
I <sub>I</sub>	Input Leakage Current	6.0	V <sub>I</sub> = V <sub>CC</sub> or GND			± 0.1		± 1		± 1	μA
I <sub>CC</sub>	Quiescent Supply Current	6.0	V <sub>I</sub> = V <sub>CC</sub> or GND			4		40		80	μA
I <sub>CC'</sub>	Active State Supply Current (1)	2.0	V <sub>I</sub> = V <sub>CC</sub> or GND		45	200		260		320	μA
		4.5	Pin 7 or 15		500	600		780		960	μA
		6.0	V <sub>IN</sub> = V <sub>CC</sub> /2		0.7	1		1.3		1.6	mA

(1) : Per Circuit

AC ELECTRICAL CHARACTERISTICS ( $C_L = 50 \text{ pF}$ , Input  $t_r = t_f = 6 \text{ ns}$ )

Symbol	Parameter	Test Condition		Value						Unit		
		$V_{CC}$ (V)		$T_A = 25^\circ\text{C}$			$-40 \text{ to } 85^\circ\text{C}$		$-55 \text{ to } 125^\circ\text{C}$			
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.	
$t_{TLH}$ $t_{THL}$	Output Transition Time	2.0			30	75		95		110	ns	
		4.5			8	15		19		22		
		6.0			7	13		16		19		
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time ( $\bar{A}$ , B - Q, $\bar{Q}$ )	2.0			102	210		265		315	ns	
		4.5			29	42		53		63		
		6.0			22	36		45		54		
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (CLR TRIGGER - Q, $\bar{Q}$ )	2.0			102	235		295		355	ns	
		4.5			31	47		59		71		
		6.0			23	40		50		60		
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time ( $\bar{\text{CLR}}$ - Q, $\bar{Q}$ )	2.0			68	160		200		240	ns	
		4.5			20	32		40		48		
		6.0			16	27		34		41		
$t_{WOUT}$	Output Pulse Width	2.0	$C_x = 100 \text{ pF}$ $R_x = 10\text{K}\Omega$		1.4						$\mu\text{s}$	
		4.5			1.2							
		6.0			1.1							
		2.0	$C_x = 0.1\mu\text{F}$ $R_x = 100\text{K}\Omega$		4.6							ms
		4.5			4.4							
		6.0			4.3							
$\Delta t_{WOUT}$	Output Pulse Width Error Between Circuits in Same Package				$\pm 1$						%	
$t_{W(H)}$ $t_{W(L)}$	Minimum Pulse Width	2.0				75		95		110	ns	
		4.5				15		19		22		
		6.0				13		16		19		
$t_{W(L)}$	Minimum Pulse Width (CLR)	2.0				75		95		110	ns	
		4.5				15		19		22		
		6.0				13		16		19		
$t_{rr}$	Minimum Retrigger Time	2.0	$C_x = 100 \text{ pF}$ $R_x = 10\text{K}\Omega$		325						ns	
		4.5			108							
		6.0			78							
		2.0	$C_x = 0.1\mu\text{F}$ $R_x = 100\text{K}\Omega$		5							$\mu\text{s}$
		4.5			1.4							
		6.0			1.2							

## CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Test Condition		Value						Unit	
		$V_{CC}$ (V)		$T_A = 25^\circ\text{C}$			$-40 \text{ to } 85^\circ\text{C}$		$-55 \text{ to } 125^\circ\text{C}$		
				Min.	Typ.	Max.	Min.	Max.	Min.		Max.
$C_{IN}$	Input Capacitance	5.0			5	10		10		10	pF
$C_{PD}$	Power Dissipation Capacitance (note 1)	5.0			162						pF

1)  $C_{PD}$  is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation.  $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}' \text{ Duty}/100 + I_{CC}''/2$  (per monostable) ( $I_{CC}'$ : Active Supply current) (Duty: %)

### Plastic DIP-16 (0.25) MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	0.77		1.65	0.030		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		17.78			0.700	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z			1.27			0.050

